Notice of References Cited Application/Control No. 10/762,724 Examiner Art Unit Page 1 of 1 U.S. PATENT DOCUMENTS Applicant(s)/Patent Under Reexamination OUDERKIRK ET AL. Art Unit Page 1 of 1

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,785,404	07-1998	Wiese, Lynn	362/555
*	В	US-6,464,366	10-2002	Lin et al.	362/616
*	С	US-2003/0189832	10-2003	Rizkin et al.	362/302
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Η	US-			
	_	US-			
	۲	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2005093728 A	04-2005	Japan	SENDA et al.	
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*	<u> </u>	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.